

March 2013

# **FDP61N20**

# N-Channel UniFET<sup>TM</sup> MOSFET

**200 V, 61 A, 41 m** $\Omega$ 

#### **Features**

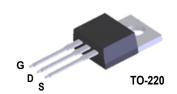
- $R_{DS(on)}$  = 41 m $\Omega$  (Max.) @  $V_{GS}$  = 10 V, ID = 30.5 A
- Low Gate Charge (Typ. 58 nC)
- Low C<sub>rss</sub> (Typ. 80 pF)
- · 100% Avalanche Tested

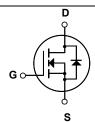
## **Applications**

- PDP TV
- · Lighting
- · Uninterruptible Power Supply
- · AC-DC Power Supply

## **Description**

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor<sup>®</sup>, s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





## **Absolute Maximum Ratings**

Symbol	Parameter		FDP61N20	Unit	
V <sub>DSS</sub>	Drain-Source Voltage		200	V	
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C - Continuous (T <sub>C</sub> = 100°C		61 38.5	A A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	244	A
$V_{GSS}$	Gate-Source voltage		±30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy		(Note 2)	1440	mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	61	А
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	41.7	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5	V/ns
P <sub>D</sub>	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate above 25°C		417 3.3	W W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C	

## **Thermal Characteristics**

Symbol	Parameter	FDP61N20	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	C/VV

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Quantity
FDP61N20	FDP61N20	TO-220	-	-	50

# $\textbf{Electrical Characteristics} \quad \textbf{T}_{\text{C}} = 25^{\circ}\text{C unless otherwise noted}$

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit
Off Charac	teristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	200			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C		0.2		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V V <sub>DS</sub> = 160V, T <sub>C</sub> = 125°C			1 10	μ <b>Α</b> μ <b>Α</b>
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30V, V <sub>DS</sub> = 0V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V$ , $V_{DS} = 0V$			-100	nA
On Charac	teristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 30.5A		0.034	0.041	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40V, I <sub>D</sub> =30.5A		44.5		S
Dynamic C	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$	-	2615	3380	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0MHz		645	840	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	80	120	pF
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 100V, I <sub>D</sub> = 61A	ı	40	90	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25\Omega$	-	215	440	ns
$t_{d(off)}$	Turn-Off Delay Time		ı	125	260	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)		170	350	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 160V, I <sub>D</sub> = 61A		58	75	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10V		19		nC
$Q_{gd}$	Gate-Drain Charge	(Note 4)		24		nC
Drain-Sour	rce Diode Characteristics and Maximun	n Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current				61	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Fe	orward Current			244	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 61A			1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>S</sub> = 61A		162		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> /dt =100A/μs		1.5		μС

#### NOTES

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 0.58mH, I\_{AS} = 61A, V\_{DD} = 50V, R\_G = 25 $\Omega$ , Starting T\_J = 25 $^{\circ}$ C
- 3.  $I_{SD} \le$  61A, di/dt  $\le$  200A/ $\mu$ s,  $V_{DD} \le$  BV $_{DSS}$ , Starting  $T_J$  = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

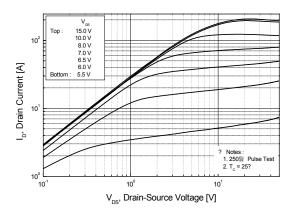


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

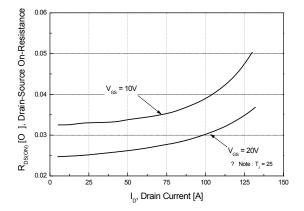


Figure 5. Capacitance Characteristics

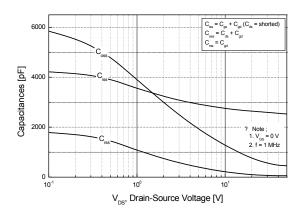


Figure 2. Transfer Characteristics

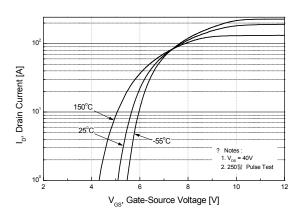


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

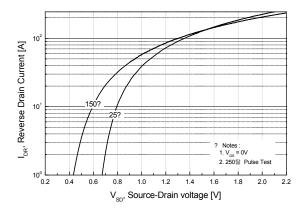
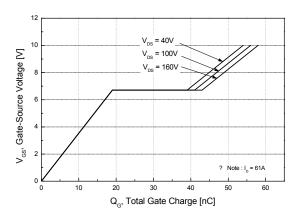


Figure 6. Gate Charge Characteristics



## **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

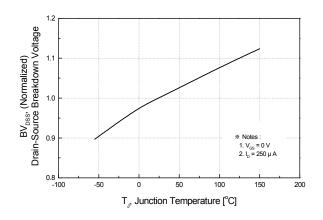


Figure 8. On-Resistance Variation vs. Temperature

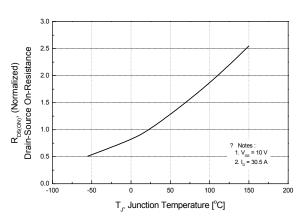


Figure 9. Safe Operating Area

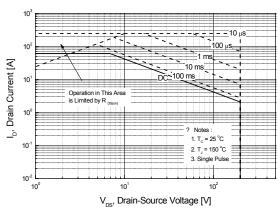


Figure 10. Maximum Drain Current vs. Case Temperature

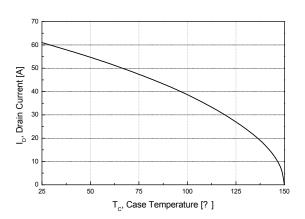
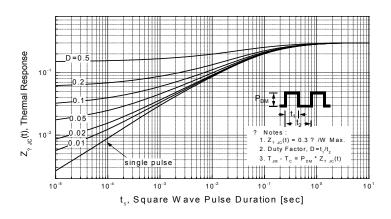
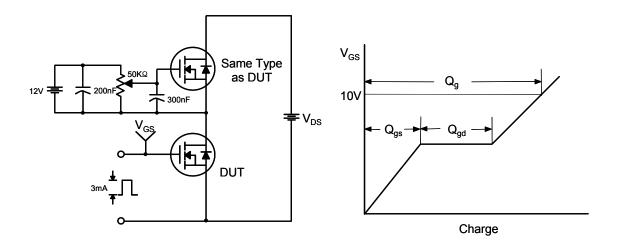


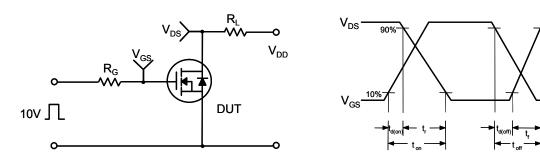
Figure 11. Transient Thermal Response Curve



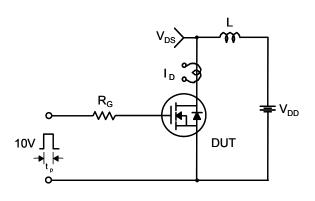
## **Gate Charge Test Circuit & Waveform**

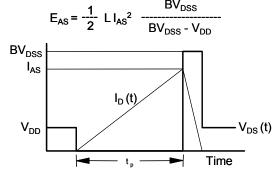


## **Resistive Switching Test Circuit & Waveforms**

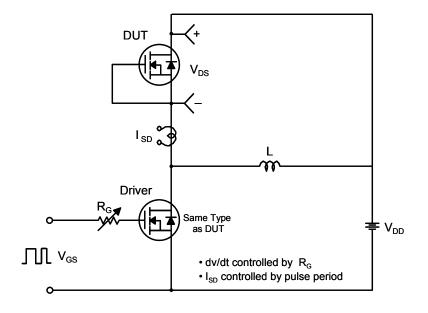


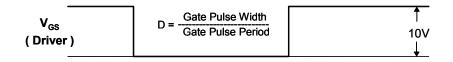
#### **Unclamped Inductive Switching Test Circuit & Waveforms**

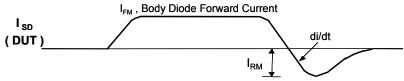




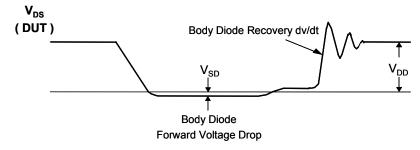
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





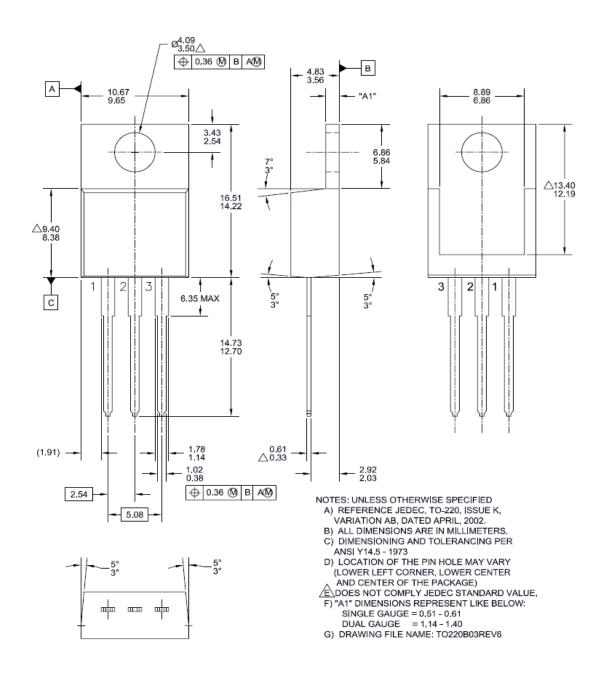


Body Diode Reverse Current



## **Mechanical Dimensions**

# TO-220B03







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